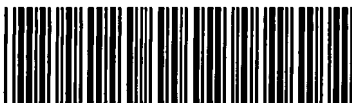


Search Notes

Application/Control No.

10/544,170

Examiner

Simon A. Goetze

Applicant(s)/Patent under
Reexamination

KANEKO ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
455	432.1	1/8/2007	SAG
455	433	1/8/2007	SAG
455	436	1/8/2007	SAG
455	440	1/8/2007	SAG
455	442	1/8/2007	SAG
455	448	1/8/2007	SAG
REVIEW	ABOVE	6/25/2007	SAG

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST image and keyword search (USPAT; US-PGUG; USOCR; EPO; JPO; DERWENT; IBM_TDB).	1/8/2007	SAG
Consulted with Nick Corsaro (Class 455).	1/8/2007	SAG